

Notice of References Cited

Application/Control No.

O9/912,527

Applicant(s)/Patent Under Reexamination IDE ET AL.

Examiner

Jaydi A. Aguirrechea

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,347,451	08-1982	Mizuyama et al.	310/59
	В	US-4,467,229	08-1984	Ogita, Tadahisa	310/157
A	С	US-6,097,116	08-2000	Hess et al.	310/58
	D	US-6,359,351	03-2002	Semba et al.	310/52
	E	US-6,288,461	09-2001	Mori et al.	310/58
	F	US-5,883,448	03-1999	Zimmerman, deceased, Hans	310/52
	G	US-6,201,323	03-2001	Semba et al.	310/52
	Н	US-6,262,502	07-2001	Semba et al.	310/52
	1	US-6,262,501	07-2001	Semba et al.	310/52
	J	US-6,265,795	07-2001	Semba et al.	310/52
	к	US-6,392,320	05-2002	Glahn et al.	310/52
	L	US-6,316,852	11-2001	Semba et al.	310/214
	М	US-6,359,361	03-2002	Wakui et al.	310/179

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04351439 A	12-1992	Japan	UBUSAWA, TAKESHI	H02K 03/487
	, 0	JP 02136050 A	05-1990	Japan	YAMASHITA, YOSHIFUMI	H02K 09/06
	Р	JP 58151845 A	09-1983	Japan	KOBAYASHI et al.	H02K 09/06
	Q				·	
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	S	· ·		-		
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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